

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

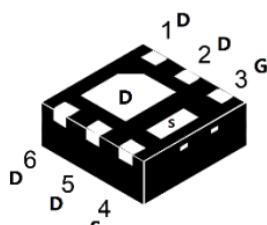
Product Summary



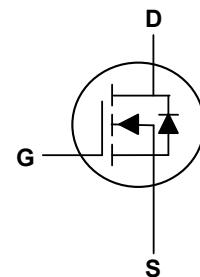
V_{DS}	40	V
I_D	30	A
$R_{DS(ON)}$ Typ (at $V_{GS}=10V$)	11	mΩ
$R_{DS(ON)}$ Typ (at $V_{GS}=4.5V$)	17	mΩ

Applications

- High Frequency Point-of-Load,Synchronous Buck Converter
- Networking DC-DC Power System
- Load Switch



DFN2X2-6L Top View



Absolute Maximum Ratings($T_c=25^\circ C$, unless otherwise noted)

Parameter	Symbol	Rating	Units
Drain-Source Voltage	V_{DS}	40	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ¹	$I_D @ T_A = 25^\circ C$	30	A
Continuous Drain Current ¹	$I_D @ T_A = 70^\circ C$	24	A
Pulsed Drain Current ²	I_{DM}	120	A
Single Pulse Avalanche Energy ³	E_{AS}	29	mJ
Total Power Dissipation ⁴	P_D	26	W
Storage Temperature Range	T_{STG}	-55 to 150	°C
Operating Junction Temperature Range	T_J	-55 to 150	°C

Thermal Characteristics

Parameter	Symbol	Typ	Max	Unit
Thermal Resistance Junction-Case ¹	$R_{\theta JC}$	---	4.8	°C/W

Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}$, $I_D=250\mu\text{A}$	40	---	---	V
Static Drain-Source On-Resistance	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=10\text{V}$, $I_D=4\text{A}$	---	11	13	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}$, $I_D=3\text{A}$	---	17	22	$\text{m}\Omega$
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{GS}}=V_{\text{DS}}$, $I_D = 250\mu\text{A}$	1.5	---	2.5	V
Drain-Source Leakage Current	I_{DSS}	$V_{\text{DS}}=40\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=25^\circ\text{C}$	---	---	1	μA
Gate-Source Leakage Current	I_{GSS}	$V_{\text{GS}}=\pm 20\text{V}$, $V_{\text{DS}}=0\text{V}$	---	---	± 100	nA
Total Gate Charge	Q_g	$V_{\text{DS}}=20\text{V}$, $V_{\text{GS}}=10\text{V}$, $I_D=15\text{A}$	---	7	---	nC
Gate-Source Charge	Q_{gs}		---	1.5	---	
Gate-Drain Charge	Q_{gd}		---	3	---	
Turn-On Delay Time	$T_{\text{d}(\text{on})}$	$V_{\text{DS}}=20\text{V}$, $V_{\text{GS}}=10\text{V}$, $R_G=3.3\Omega$, $I_D=1\text{A}$	---	7	---	ns
Rise Time	T_r		---	11	---	
Turn-Off Delay Time	$T_{\text{d}(\text{off})}$		---	24	---	
Fall Time	T_f		---	17	---	
Input Capacitance	C_{iss}	$V_{\text{DS}}=20\text{V}$, $V_{\text{GS}}=0\text{V}$, $f=1\text{MHz}$	---	407	---	pF
Output Capacitance	C_{oss}		---	196	---	
Reverse Transfer Capacitance	C_{rss}		---	7.7	---	

Drain-Source Diode Characteristics

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Diode Forward Voltage ²	V_{SD}	$V_{\text{GS}}=0\text{V}$, $I_s=40\text{A}$, $T_J=25^\circ\text{C}$	---	---	1.2	V

Note:

1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

2.The data tested by pulsed , pulse width $\leq 300\text{us}$, duty cycle $\leq 2\%$

Typical Characteristics

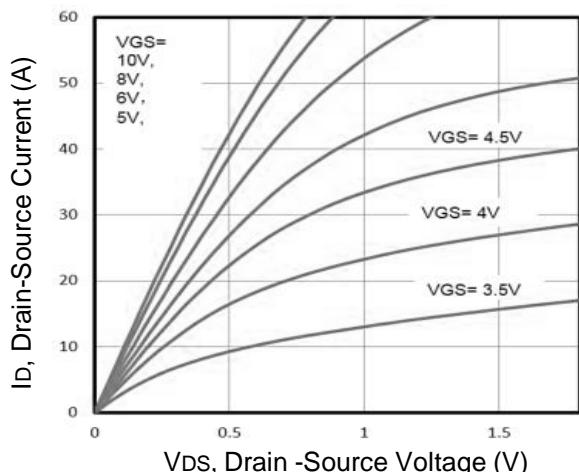


Fig1. Typical Output Characteristics

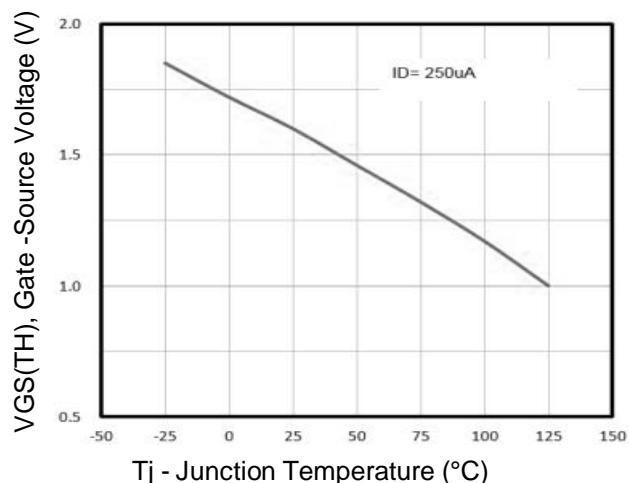


Fig2. Normalized Threshold Voltage Vs. Temperature

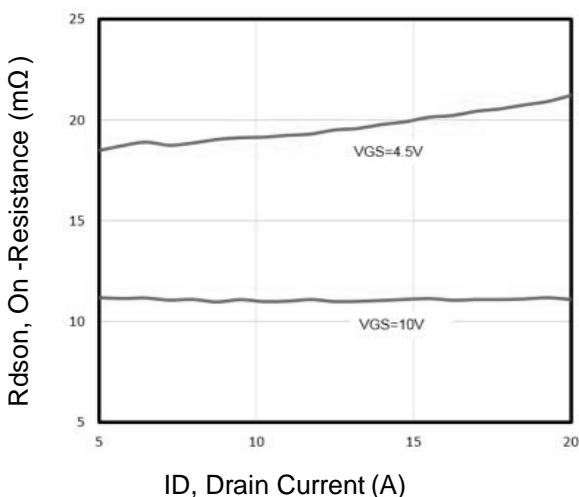


Fig3. On-Resistance vs. Drain Current and Gate

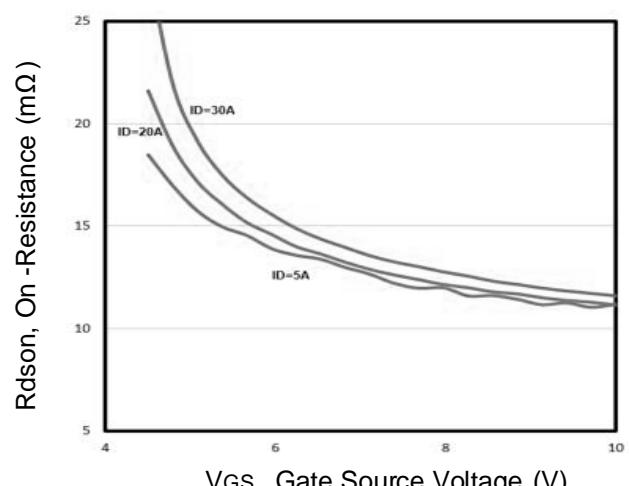


Fig4. On-Resistance vs. Gate Source Voltage

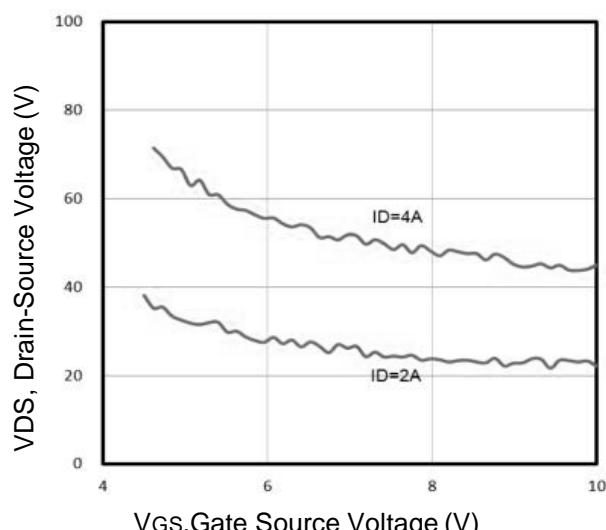


Fig5. Drain-Source Voltage vs Gate-Source Voltage

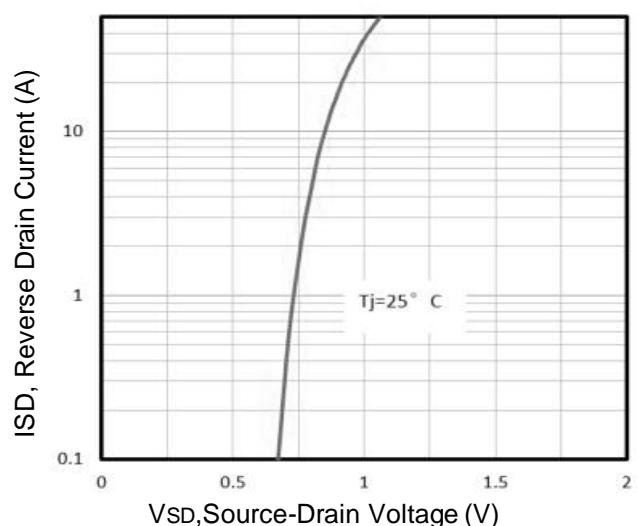
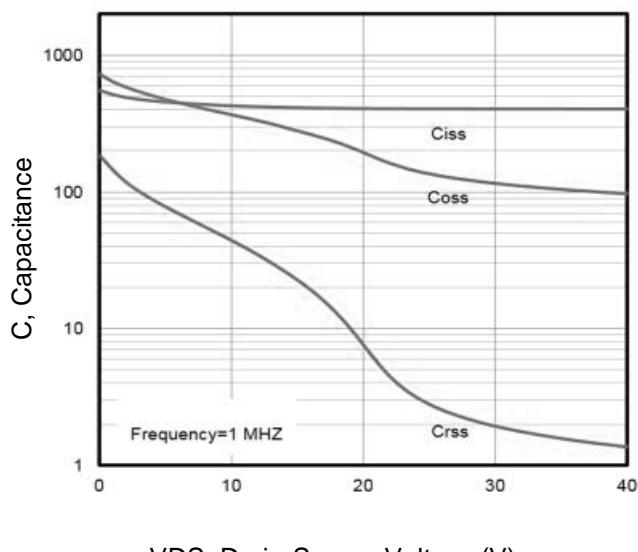
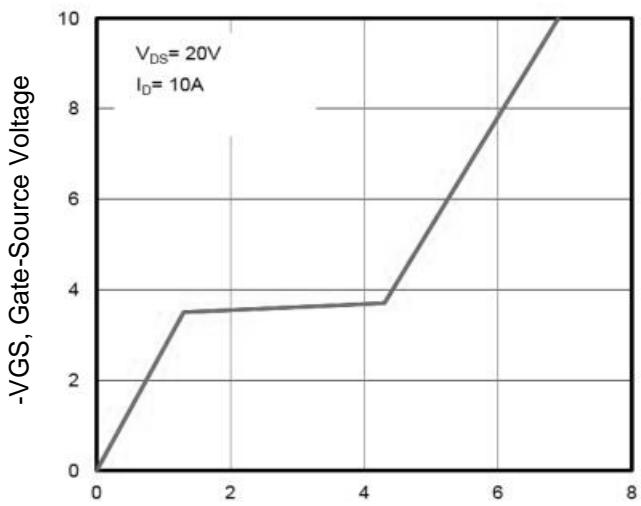
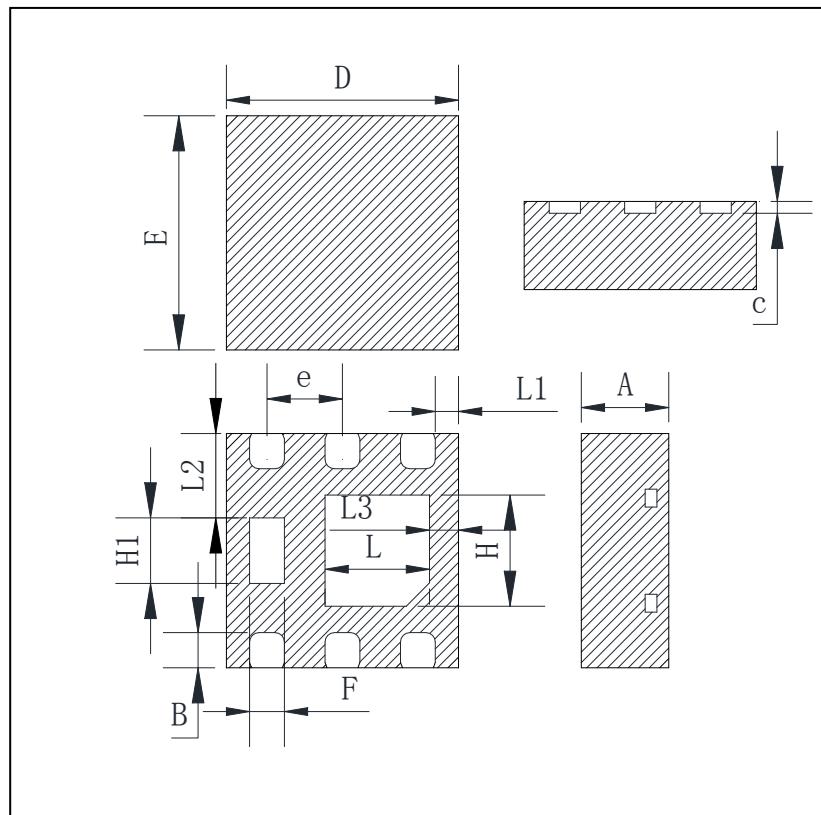


Fig6. Typical Source-Drain Diode Forward Voltage



VDS, Drain-Source Voltage (V)

Fig7. Typical Capacitance Vs. Drain-Source Voltage $-V_{GS}$, Gate-Source Voltage**Fig8.** Typical Gate Charge Vs. Gate-Source Voltage

DFN2X2-6L Package Outline Data

Symbol	Min	Typ	Max
A	0.70	0.75	0.80
B	0.25	0.30	0.35
C	0.153	0.203	0.253
D	1.90	2.00	2.10
E	1.90	2.00	2.10
e	0.60	0.65	0.70
F	0.25	0.30	0.35
H	0.90	1.00	1.10
H1	0.50	0.60	0.65
L	0.80	0.90	1.00
L1	0.15	0.20	0.25
L2	0.60	0.70	0.80
L3	0.25	0.30	0.35

UNIT: mm